

# ETSI TS 138 141-1 V18.13.0 (2026-04)



TECHNICAL SPECIFICATION

**5G;  
NR;**

**Base Station (BS) conformance testing  
Part 1: Conducted conformance testing  
(3GPP TS 38.141-1 version 18.13.0 Release 18)**



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**Reference**

RTS/TSGR-0438141-1vid0

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**Keywords**

5G

**ETSI**

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